Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/593,340	INOUE ET AL.	
Examiner	Art Unit	
CHRIS H. CHU	2874	

	SEARCHED				
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	ST: USPAT G-PUB (see ed text)	3/31/2008	/CC/	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
updated previous searches	3/31/2008	ICCI		